



# BST100N045CT

## Silicon N-Channel MOSFET

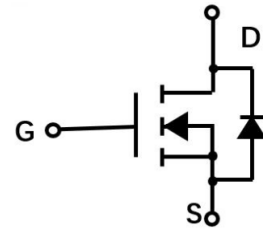
### Package

### Features

- 100V, 150A
- $R_{DS(on)} = 4.5m\Omega$  (Max.) @  $V_{GS} = 10V$ ,  $I_D = 50A$
- Low  $R_{DS(on)}$  & FOM
- Extremely low switching loss
- Excellent stability and uniformity
- 100% UIS tested , 100%  $\Delta V_{DS}$  Tested
- RoHS and Halogen-Free Compliant



TO-220



### Absolute Maximum Ratings $T_C=25^\circ\text{C}$ unless otherwise specified

Symbol	Parameter		Max.	Units
$V_{DSS}$	Drain-Source Voltage		100	V
$V_{GSS}$	Gate-Source Voltage		$\pm 20$	V
$I_D$	Continuous Drain Current <sup>note5</sup>	$T_C = 25^\circ\text{C}$	150	A
$I_D$	Continuous Drain Current <sup>note5</sup>	$T_C = 100^\circ\text{C}$	94.5	A
$I_{DM}$	Pulsed Drain Current <sup>note3</sup>		600	A
$P_D$	Power Dissipation <sup>note2</sup>	$T_C = 25^\circ\text{C}$	167	W
$I_{AS}$	Avalanche Current <sup>note3,6</sup>		21	A
$E_{AS}$	Single Pulse Avalanche Energy <sup>note3,6</sup>		210	mJ
$R_{\theta JC}$	Thermal Resistance, Junction to Case		0.75	$^\circ\text{C/W}$
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient <sup>note1,4</sup>		50	$^\circ\text{C/W}$
$T_J, T_{STG}$	Operating and Storage Temperature Range		-55 to +150	$^\circ\text{C}$

## Electrical Characteristics $T_C=25^{\circ}\text{C}$ unless otherwise specified

Symbol	Parameter	Test Condition	Min.	Typ.	Max.	Units
Off Characteristic						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> = 0V, I <sub>D</sub> = 250μA	100	-	-	V
I <sub>DSS</sub>	Drain-Source Leakage Current	V <sub>DS</sub> = 80V, V <sub>GS</sub> = 0V	-	-	1	μA
I <sub>GSS</sub>	Gate to Body Leakage Current	V <sub>DS</sub> = 0V, V <sub>GS</sub> = ±20V	-	-	±100	nA
On Characteristics						
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250μA	1.2	1.8	2.6	V
R <sub>DS(on)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> = 10V, I <sub>D</sub> = 50A	-	4.0	4.5	mΩ
		V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 30A	-	6.5	7.5	mΩ
R <sub>g</sub>	Gate Resistance	V <sub>DS</sub> = V <sub>GS</sub> =0V, f = 1.0MHz	-	1.66	-	Ω
Dynamic Characteristics						
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> = 50V, V <sub>GS</sub> = 0V, f = 1.0MHz	-	3470	-	pF
C <sub>oss</sub>	Output Capacitance		-	1560	-	pF
C <sub>rss</sub>	Reverse Transfer Capacitance		-	79	-	pF
Switching Characteristics						
Q <sub>g</sub>	Total Gate Charge	V <sub>DS</sub> = 50V, I <sub>D</sub> = 50A, V <sub>GS</sub> = 10V	-	74.5	-	nC
Q <sub>gs</sub>	Gate-Source Charge		-	14.2	-	
Q <sub>gd</sub>	Gate-Drain(“Miller”) Charge		-	22.5	-	
t <sub>d(on)</sub>	Turn-On Delay Time	V <sub>DS</sub> = 50V, I <sub>D</sub> = 50A, R <sub>G</sub> = 3Ω, V <sub>GS</sub> =10V	-	14.3	-	ns
t <sub>r</sub>	Turn-On Rise Time		-	20.8	-	
t <sub>d(off)</sub>	Turn-Off Delay Time		-	57.7	-	
t <sub>f</sub>	Turn-Off Fall Time		-	31.89	-	
Diode Characteristics						
I <sub>S</sub>	Continuous Source Current		-	-	150	A
V <sub>SD</sub>	Diode Forward Voltage	I <sub>S</sub> =50A . V <sub>GS</sub> = 0V	-	0.80	1.0	V
t <sub>rr</sub>	Reverse Recovery Time	I <sub>SD</sub> =30A,	-	115	-	ns
Q <sub>rr</sub>	Reverse Recovery Charge	dI <sub>SD</sub> /dt=100A/μs	-	520	-	nC

### Notes:

1. The value of  $R_{\theta JC}$  is measured in a still air environment with  $T_A = 25^{\circ}\text{C}$  and the maximum allowed junction temperature of  $150^{\circ}\text{C}$ . The value in any given application depends on the user's specific board design.
2. The power dissipation  $P_D$  is based on  $T_{J(MAX)}=150^{\circ}\text{C}$ , using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.
3. Single pulse width limited by junction temperature  $T_{J(MAX)}=150^{\circ}\text{C}$ .
4. The  $R_{\theta JA}$  is the sum of the thermal impedance from junction to case  $R_{\theta JC}$  and case to ambient.
5. The maximum current rating is package limited.
6. The EAS data shows Max. rating. The test condition is  $V_{DS}=50V, V_{GS}=10V, L=0.5mH$

## Typical Performance Characteristics

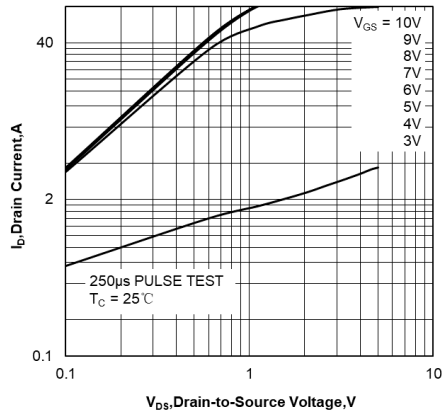


Figure 1. Output Characteristics

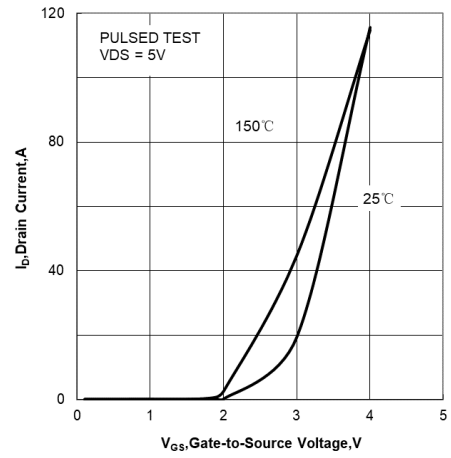


Figure 2. Transfer Characteristics

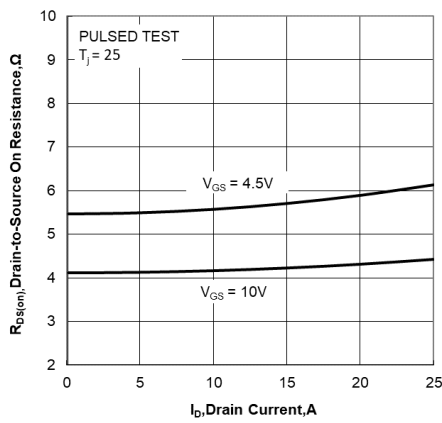


Figure 3. Drain-to-Source On Resistance  
vs Drain Current

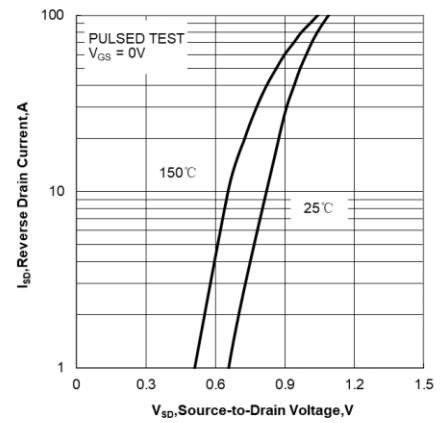


Figure 4. Body Diode Forward Voltage  
vs Source Current and Temperature

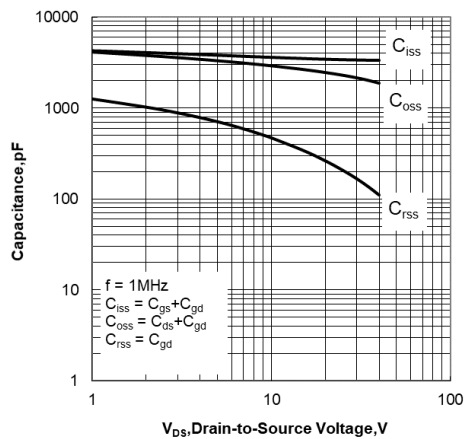


Figure 5. Capacitance Characteristics

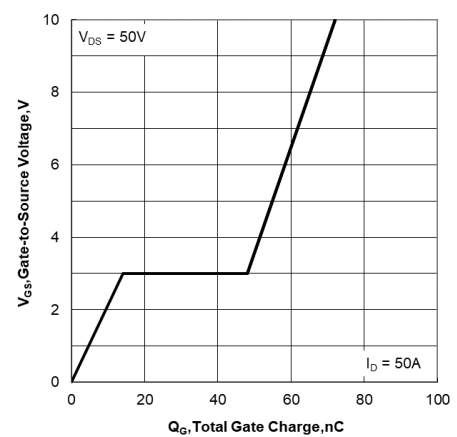
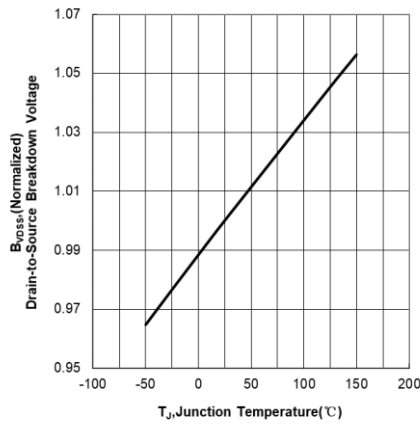
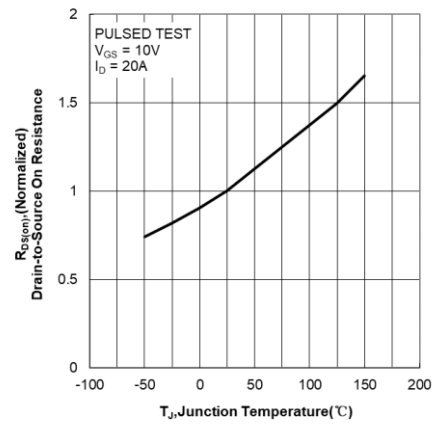


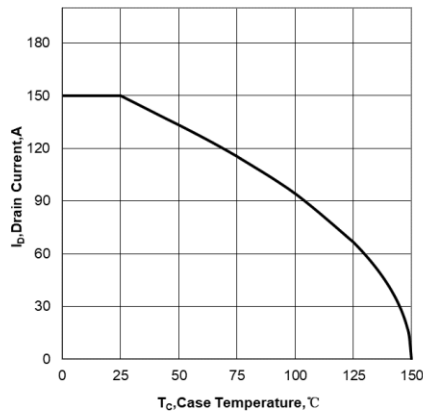
Figure 6. Gate Charge Characteristics



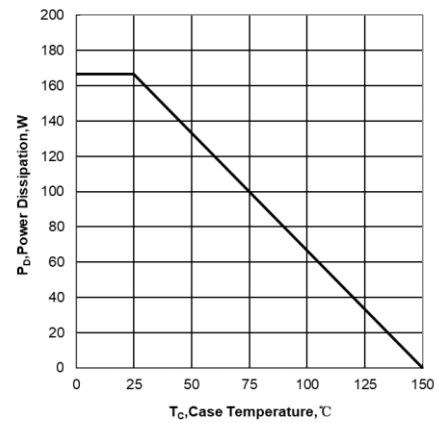
**Figure 7. Normalized Breakdown Voltage vs Junction Temperature**



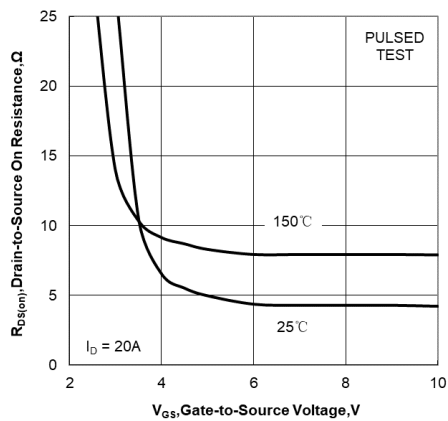
**Figure 8. Normalized On Resistance vs Junction Temperature**



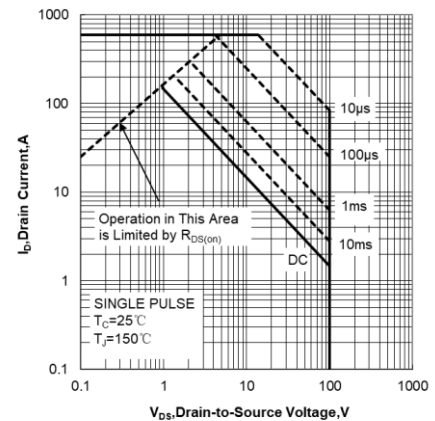
**Figure 9. Maximum Continuous Drain Current vs Case Temperature**



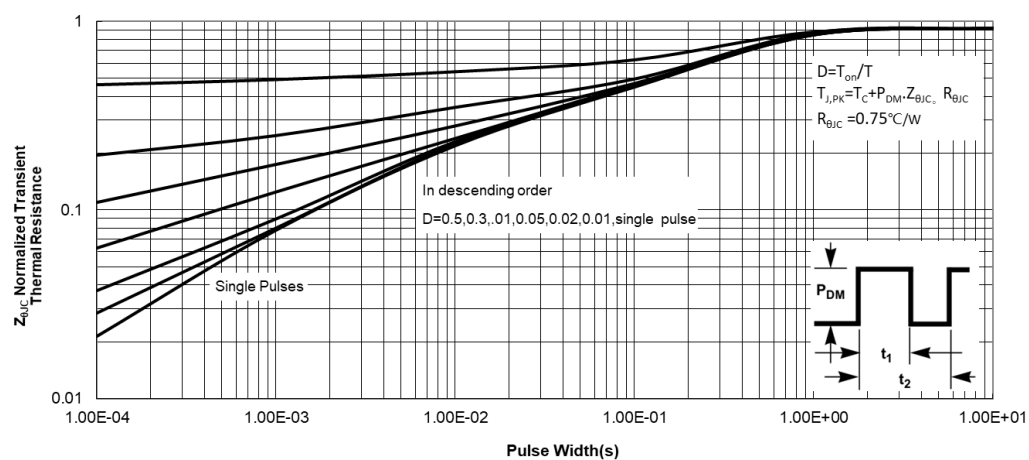
**Figure 10. Maximum Power Dissipation vs Case Temperature**



**Figure 11. Drain-to-Source On Resistance vs Gate Voltage and Drain Current**



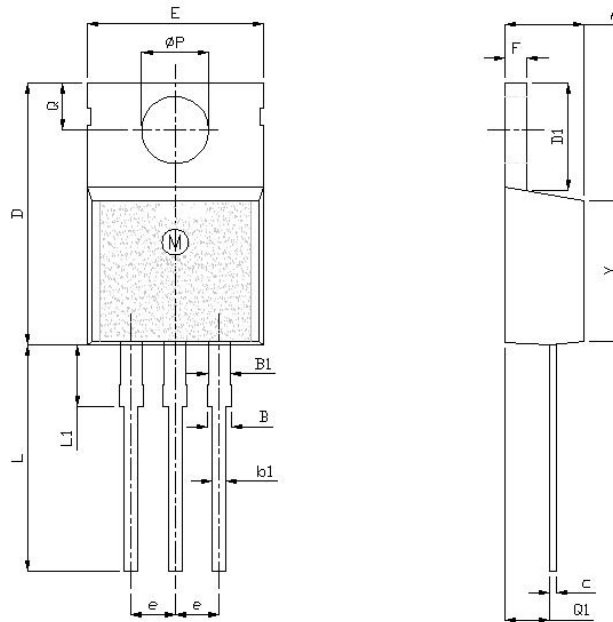
**Figure 12. Maximum Safe Operating Area**



**Figure 13. Maximum Effective Transient Thermal Impedance, Junction-to-Case**

# TO-220 Package Mechanical Data

## Mechanical Dimensions for TO-220



UNIT:mm

SYMBOL	MIN	NOM	MAX
A	4		4.8
B	1.2		1.4
B1	1		1.4
b1	0.75		0.95
c	0.4		0.55
D	15		16.5
D1	5.9		6.9
E	9.9		10.7
e	2.44	2.54	2.64
F	1.1		1.4
L	12.5		14.5
L1	3	3.5	4
$\phi P$	3.7	3.8	3.9
Q	2.5		3
Q1	2		2.9
Y	8.02	8.12	8.22